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SEMICONDUCTOR TM

FQPF4P40 400V P-Channel MOSFET

General Description

These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

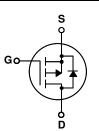
This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for electronic lamp ballast based on complimentary half bridge.

Features

- -2.4A, -400V, R_{DS(on)} = 3.1Ω @V_{GS} = -10 V
 Low gate charge (typical 18 nC)
 Low Crss (typical 11 pF)

- Fast switching
- 100% avalanche tested
- Improved dv/dt capability





August 2000

ТΜ

Absolute Maximum Ratings T_C = 25°C unless otherwise noted

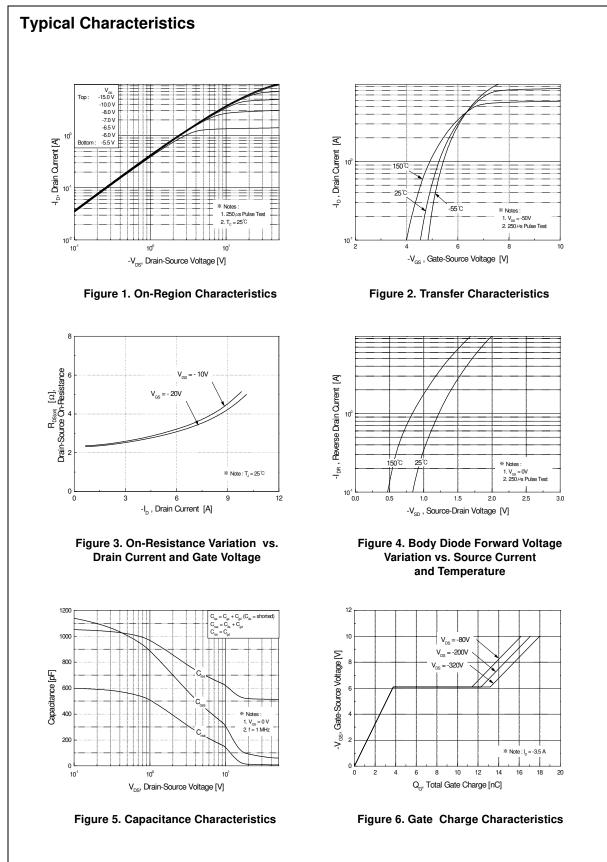
| Symbol | Parameter | | FQPF4P40 | Units |
|-----------------------------------|---|----------|-------------|-------|
| V _{DSS} | Drain-Source Voltage | | -400 | V |
| I _D | Drain Current - Continuous (T _C = 25° | C) | -2.4 | A |
| | - Continuous (T _C = 100 | °C) | -1.52 | A |
| I _{DM} | Drain Current - Pulsed | (Note 1) | -9.6 | A |
| V _{GSS} | Gate-Source Voltage | | ± 30 | V |
| E _{AS} | Single Pulsed Avalanche Energy | (Note 2) | 260 | mJ |
| I _{AR} | Avalanche Current | (Note 1) | -2.4 | A |
| E _{AR} | Repetitive Avalanche Energy | (Note 1) | 3.9 | mJ |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | | -4.5 | V/ns |
| PD | Power Dissipation (T _C = 25°C) | | 39 | W |
| | - Derate above 25°C | | 0.31 | W/°C |
| T _J , T _{STG} | Operating and Storage Temperature Range | | -55 to +150 | °C |
| Τ _L | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds | | 300 | °C |

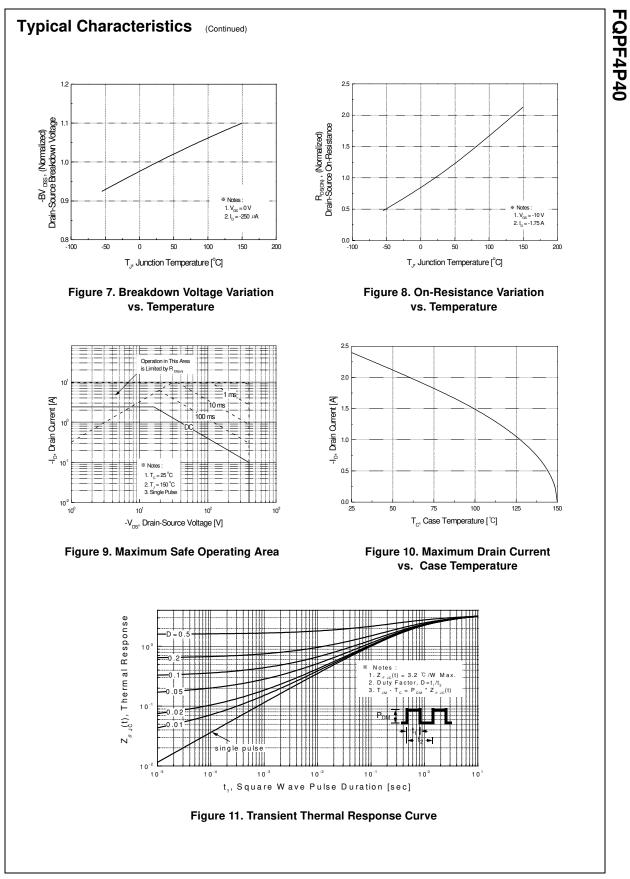
Thermal Characteristics

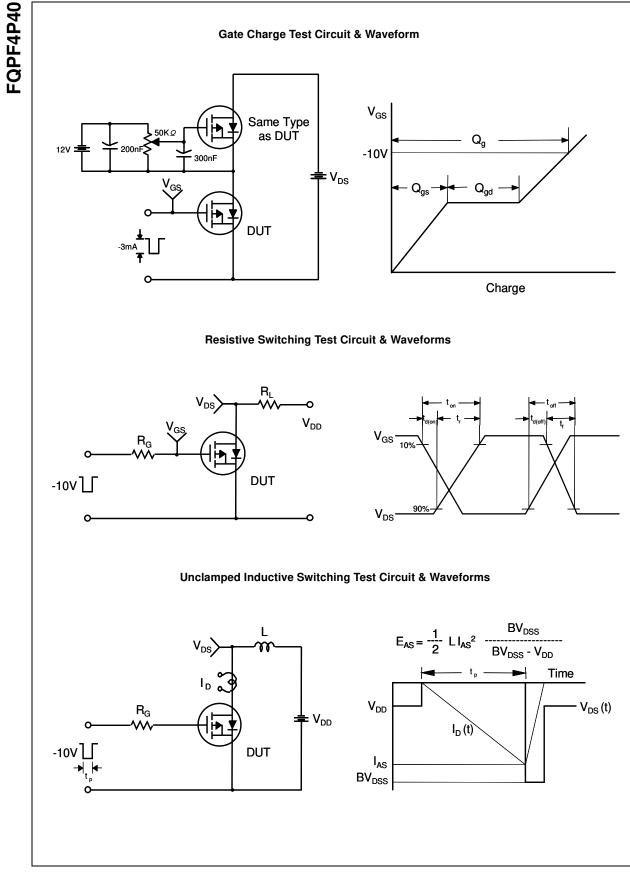
| Symbol | Parameter | Тур | Max | Units |
|-----------------------|---|-----|------|-------|
| $R_{	extsf{	heta}JC}$ | Thermal Resistance, Junction-to-Case | | 3.2 | °C/W |
| R_{\thetaJA} | Thermal Resistance, Junction-to-Ambient | | 62.5 | °C/W |

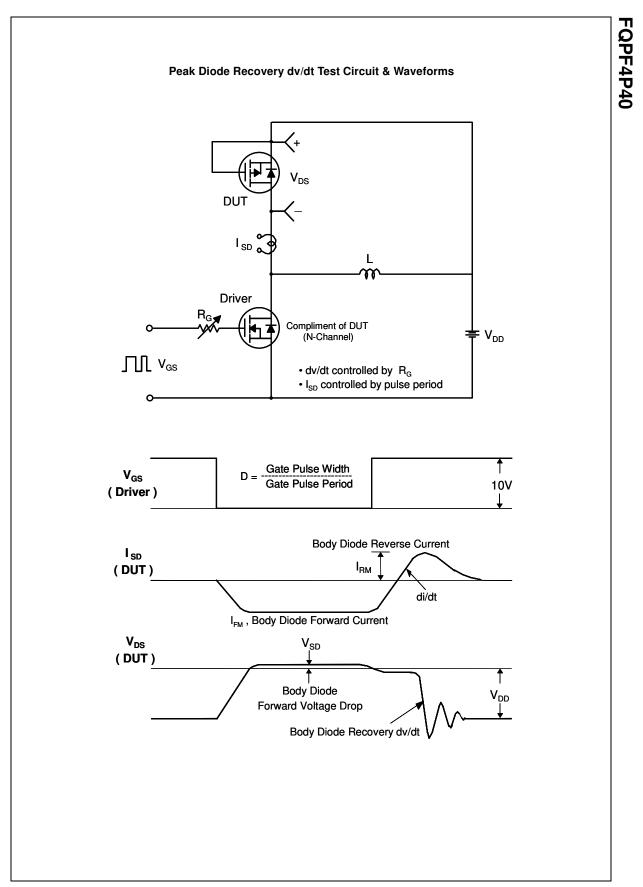
| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|---|--|---|------|------|------|-------|
| Off Ch | aracteristics | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} = 0 V, I _D = -250 μA | -400 | | | V |
| ΔBV _{DSS} / ΔT _J | Breakdown Voltage Temperature Coefficient | $I_D = -250 \ \mu\text{A}$, Referenced to 25°C | | 0.36 | | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = -400 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ | | | -1 | μA |
| | | $V_{DS} = -320 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$ | | | -10 | μA |
| I _{GSSF} | Gate-Body Leakage Current, Forward | $V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$ | | | -100 | nA |
| I _{GSSR} | Gate-Body Leakage Current, Reverse | $V_{GS} = 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$ | | | 100 | nA |
| On Ch | aracteristics | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$ | -3.0 | | -5.0 | V |
| R _{DS(on)} | Static Drain-Source On-Resistance | $V_{GS} = -10 \text{ V}, \text{ I}_{D} = -1.2 \text{ A}$ | | 2.44 | 3.1 | Ω |
| 9 _{FS} | Forward Transconductance | $V_{DS} = -50 \text{ V}, I_D = -1.2 \text{ A}$ (Note 4) | | 2.4 | | S |
| | ic Characteristics | 1 | 1 | | 1 | 1 |
| C _{iss} | Input Capacitance | $V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ | | 520 | 680 | pF |
| C _{oss} | Output Capacitance | f = 1.0 MHz | | 80 | 105 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 11 | 15 | pF |
| Switch | ing Characteristics | | | | | |
| t _{d(on)} | Turn-On Delay Time | V _{DD} = -200 V, I _D = -3.5 A, | | 13 | 35 | ns |
| t _r | Turn-On Rise Time | $R_{G} = 25 \Omega$ | | 55 | 120 | ns |
| t _{d(off)} | Turn-Off Delay Time | | | 35 | 80 | ns |
| t _f | Turn-Off Fall Time | (Note 4, 5) | | 37 | 85 | ns |
| Qg | Total Gate Charge | V _{DS} = -320 V, I _D = -3.5 A, | | 18 | 23 | nC |
| Q _{gs} | Gate-Source Charge | V _{GS} = -10 V | | 3.8 | | nC |
| Q _{gd} | Gate-Drain Charge | (Note 4, 5) | | 9.4 | | nC |
| | | od Marianana Datin na | | | | |
| Is | Source Diode Characteristics an Maximum Continuous Drain-Source Dio | | | | -2.4 | A |
| | Maximum Pulsed Drain-Source Diode F | | | | -9.6 | A |
| | Drain-Source Diode Forward Voltage | | | | -5.0 | V |
| I _{SM} | Drain-Source Dioge Forward Vollage | 00 / 0 | | 260 | | ns |
| I _{SM} V _{SD} | | $V_{GS} = 0 V, I_{S} = -3.5 A.$ | | 200 | | |
| I _{SM} V _{SD} t _{rr} | Reverse Recovery Time Reverse Recovery Charge | $V_{GS} = 0 V, I_S = -3.5 A,$ $dI_F / dt = 100 A/\mu s$ (Note 4) | | 1.4 | | μC |



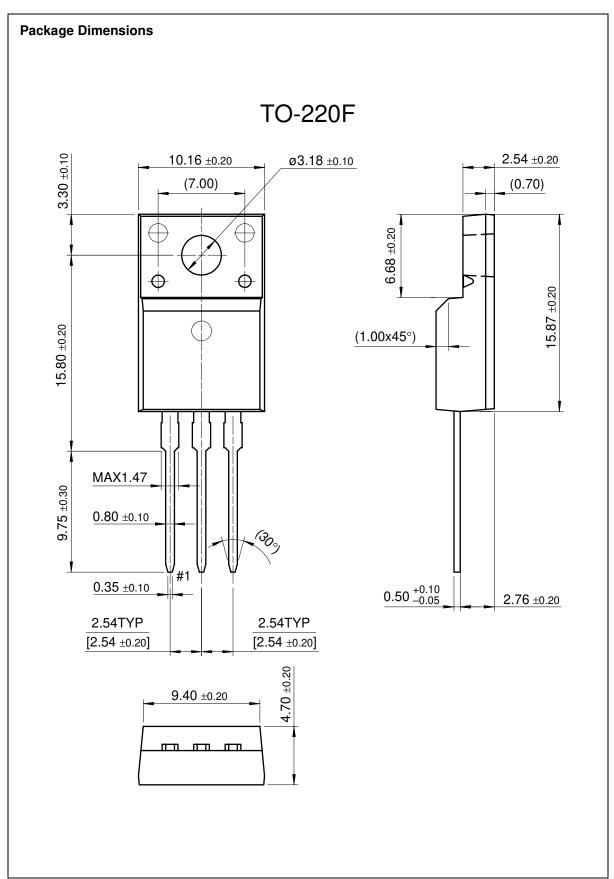








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|--------------------------|---------------------------|---|
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